

Search Notes

Application/Control No.

10/691,212

Examiner

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Applicant(s)/Patent under
Reexamination

DORNBUSCH ET AL.

Art Unit

2815

SEARCHED

Class	Subclass	Date	Examiner
257	E23.052, E23.079, 786 & 778	4/13/2006	C.C.
257	686	4/13/2006	C.C.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched in US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; and IBM_TDB;	4/13/2006	C.C.